


“Half Bridge” High Speed IGBT INT-A-PAK, 200 A



INT-A-PAK IGBT

FEATURES

- Trench IGBT technology
- Gen 4 FRED Pt[®] anti-parallel diodes with ultra soft reverse recovery characteristics
- Very low switching losses
- Al₂O₃ DBC
- UL approved file E78996 
- Designed for industrial level
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912


RoHS
COMPLIANT

BENEFITS

- Optimized for high current inverter stages
- Direct mounting on heatsink
- Very low junction to case thermal resistance
- Low EMI

PRIMARY CHARACTERISTICS

| | |
|--|-----------------|
| V_{CES} | 650 V |
| I_C (DC) at $T_C = 80\text{ }^\circ\text{C}$ | 144 A |
| $V_{CE(on)}$ (typical) at $I_C = 200\text{ A}$, $T_J = 25\text{ }^\circ\text{C}$ | 1.83 V |
| Chip level $V_{CE(on)}$ at 200 A, 25 °C | 1.70 V |
| Speed | 8 kHz to 30 kHz |
| Package | INT-A-PAK |
| Circuit configuration | Half bridge |

ABSOLUTE MAXIMUM RATINGS

| PARAMETER | SYMBOL | TEST CONDITIONS | MAX. | UNITS |
|--------------------------------------|------------|--|-------------|------------------|
| Collector to emitter voltage | V_{CES} | | 650 | V |
| Continuous collector current | I_C | $T_C = 25\text{ }^\circ\text{C}$ | 193 | A |
| | | $T_C = 80\text{ }^\circ\text{C}$ | 144 | |
| Pulsed collector current | I_{CM} | $T_J = 175\text{ }^\circ\text{C}$, $t_p = 6\text{ ms}$, $V_{GE} = 15\text{ V}$ | 450 | |
| Clamped inductive load current | I_{LM} | | 405 | |
| Diode continuous forward current | I_F | $T_C = 25\text{ }^\circ\text{C}$ | 144 | |
| | | $T_C = 80\text{ }^\circ\text{C}$ | 108 | |
| Maximum non-repetitive peak current | I_{FSM} | 10 ms sine or 6 ms rectangular pulse | 1080 | |
| Gate to emitter voltage | V_{GE} | | ± 20 | V |
| Maximum power dissipation (IGBT) | P_D | $T_C = 25\text{ }^\circ\text{C}$ | 517 | W |
| | | $T_C = 80\text{ }^\circ\text{C}$ | 328 | |
| Maximum power dissipation (Diode) | P_D | $T_C = 25\text{ }^\circ\text{C}$ | 366 | |
| | | $T_C = 80\text{ }^\circ\text{C}$ | 232 | |
| RMS isolation voltage | V_{ISOL} | Any terminal to case, $t = 1\text{ min}$ | 2500 | V |
| Operating junction temperature range | T_J | | -40 to +175 | $^\circ\text{C}$ |
| Storage temperature range | T_{STG} | | -40 to +150 | $^\circ\text{C}$ |



| ELECTRICAL SPECIFICATIONS ($T_J = 25\text{ }^\circ\text{C}$ unless otherwise noted) | | | | | | |
|---|--------------------------------|--|------|------|------|----------------------|
| PARAMETER | SYMBOL | TEST CONDITIONS | MIN. | TYP. | MAX. | UNITS |
| Collector to emitter breakdown voltage | $V_{(BR)CES}$ | $V_{GE} = 0\text{ V}, I_C = 400\text{ }\mu\text{A}$ | 650 | - | - | |
| Collector to emitter voltage | $V_{CE(on)}$ | $V_{GE} = 15\text{ V}, I_C = 100\text{ A}$ | - | 1.46 | - | V |
| | | $V_{GE} = 15\text{ V}, I_C = 200\text{ A}$ | - | 1.83 | 2.3 | |
| | | $V_{GE} = 15\text{ V}, I_C = 100\text{ A}, T_J = 125\text{ }^\circ\text{C}$ | - | 1.59 | - | |
| | | $V_{GE} = 15\text{ V}, I_C = 200\text{ A}, T_J = 125\text{ }^\circ\text{C}$ | - | 2.13 | - | |
| Gate threshold voltage | $V_{GE(th)}$ | $V_{CE} = V_{GE}, I_C = 2.0\text{ mA}$ | 3 | 3.9 | 5 | |
| Temperature coefficient of threshold voltage | $\Delta V_{GE(th)}/\Delta T_J$ | $V_{CE} = V_{GE}, I_C = 2.0\text{ mA}$ ($25\text{ }^\circ\text{C}$ to $125\text{ }^\circ\text{C}$) | - | -10 | - | mV/ $^\circ\text{C}$ |
| Forward transconductance | g_{fe} | $V_{CE} = 20\text{ V}, I_C = 200\text{ A}$ | - | 238 | - | S |
| Transfer characteristics | V_{GE} | $V_{CE} = 20\text{ V}, I_C = 200\text{ A}$ | - | 6.3 | - | V |
| Collector to emitter leakage current | I_{CES} | $V_{GE} = 0\text{ V}, V_{CE} = 650\text{ V}$ | - | 0.2 | 100 | μA |
| | | $V_{GE} = 0\text{ V}, V_{CE} = 650\text{ V}, T_J = 125\text{ }^\circ\text{C}$ | - | 0.1 | - | mA |
| Diode forward voltage drop | V_{FM} | $I_{FM} = 100\text{ A}$ | - | 1.73 | 2.5 | V |
| | | $I_{FM} = 200\text{ A}$ | - | 2.05 | - | |
| | | $I_{FM} = 100\text{ A}, T_J = 125\text{ }^\circ\text{C}$ | - | 1.37 | - | |
| | | $I_{FM} = 200\text{ A}, T_J = 125\text{ }^\circ\text{C}$ | - | 1.75 | - | |
| Gate to emitter leakage current | I_{GES} | $V_{GE} = \pm 20\text{ V}$ | - | - | 240 | nA |

| SWITCHING CHARACTERISTICS | | | | | | | | |
|----------------------------------|--------------|---|---|------|------|-------|----|----|
| PARAMETER | SYMBOL | TEST CONDITIONS | MIN. | TYP. | MAX. | UNITS | | |
| Total gate charge (turn-on) | Q_g | $I_C = 200\text{ A}$ $V_{CC} = 520\text{ V}$ $V_{GE} = 15\text{ V}$ | - | 488 | - | nC | | |
| Gate to emitter charge (turn-on) | Q_{ge} | | - | 58 | - | | | |
| Gate to collector (turn-on) | Q_{gc} | | - | 137 | - | | | |
| Turn-on switching loss | E_{on} | $V_{CC} = 325\text{ V}, I_C = 200\text{ A}, R_g = 27\text{ }\Omega,$ $L = 500\text{ }\mu\text{H}, V_{GE} = \pm 15\text{ V}$ | - | 2.34 | - | mJ | | |
| Turn-off switching loss | E_{off} | | - | 3.77 | - | | | |
| Total switching loss | E_{tot} | | - | 6.11 | - | | | |
| Turn-on delay time | $t_{d(on)}$ | | $V_{CC} = 325\text{ V}, I_C = 200\text{ A}, R_g = 27\text{ }\Omega,$ $L = 500\text{ }\mu\text{H}, V_{GE} = \pm 15\text{ V}$ $T_J = 125\text{ }^\circ\text{C}$ | - | 111 | - | ns | |
| Rise time | t_r | | | - | 120 | - | | |
| Turn-off delay time | $t_{d(off)}$ | | | - | 454 | - | | |
| Fall time | t_f | | | - | 64 | - | | |
| Turn-on switching loss | E_{on} | | | - | 2.82 | - | | mJ |
| Turn-off switching loss | E_{off} | | | - | 3.86 | - | | |
| Total switching loss | E_{tot} | | | - | 6.68 | - | | |
| Turn-on delay time | $t_{d(on)}$ | $V_{CC} = 325\text{ V}, I_C = 200\text{ A}, R_g = 27\text{ }\Omega,$ $L = 500\text{ }\mu\text{H}, V_{GE} = \pm 15\text{ V}$ $T_J = 125\text{ }^\circ\text{C}$ | - | 79 | - | ns | | |
| Rise time | t_r | | - | 82 | - | | | |
| Turn-off delay time | $t_{d(off)}$ | | - | 306 | - | | | |
| Fall time | t_f | | - | 34 | - | | | |
| Reverse bias safe operating area | RBSOA | $I_C = 405\text{ A}, R_g = 27\text{ }\Omega, V_{CC} = 325\text{ V},$ $V_p = 650\text{ V}, V_{GE} = 15\text{ V to } -5\text{ V}, T_J = 175\text{ }^\circ\text{C}$ | Fullsquare | | | | | |
| Diode reverse recovery time | t_{rr} | $I_F = 50\text{ A}, di_F/dt = 500\text{ A}/\mu\text{s}$ $V_{rr} = 200\text{ V}, T_J = 25\text{ }^\circ\text{C}$ | - | 72 | - | ns | | |
| Diode peak reverse current | I_{rr} | | - | 13 | - | A | | |
| Diode recovery charge | Q_{rr} | | - | 466 | - | nC | | |
| Diode reverse recovery time | t_{rr} | $I_F = 50\text{ A}, di_F/dt = 500\text{ A}/\mu\text{s}$ $V_{rr} = 200\text{ V}, T_J = 125\text{ }^\circ\text{C}$ | - | 146 | - | ns | | |
| Diode peak reverse current | I_{rr} | | - | 28 | - | A | | |
| Diode recovery charge | Q_{rr} | | - | 2064 | - | nC | | |



| THERMAL AND MECHANICAL SPECIFICATIONS | | | | | | |
|---|--------------------------|-----------------|------|------|------|-------|
| PARAMETER | SYMBOL | TEST CONDITIONS | MIN. | TYP. | MAX. | UNITS |
| Operating junction temperature range | T_J | | -40 | - | 175 | °C |
| Storage temperature range | T_{Stg} | | -40 | - | 150 | |
| Junction to case per leg | IGBT | | - | - | 0.29 | °C/W |
| | Diode | | | | | |
| Case to sink per module (conductive grease applied) | R_{thCS} | | - | 0.05 | - | |
| Mounting torque | case to heatsink | | - | - | 4 | |
| | case to terminal 1, 2, 3 | | - | - | 3 | |
| Weight | | | - | 150 | - | g |

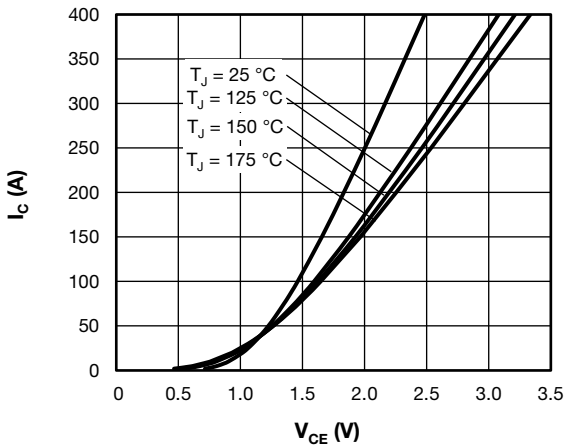


Fig. 1 - Typical Trench IGBT Output Characteristics, $V_{GE} = 15\text{ V}$

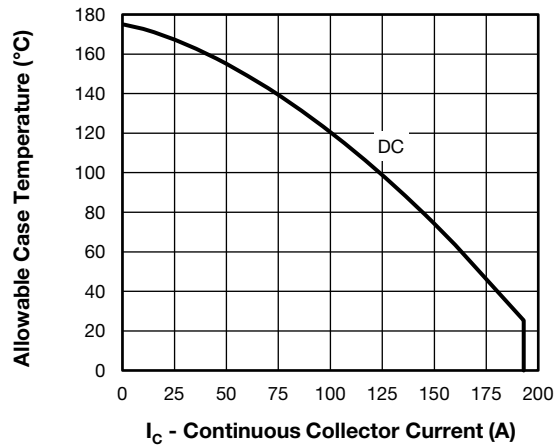


Fig. 3 - Maximum Trench IGBT Continuous Collector Current vs. Case Temperature

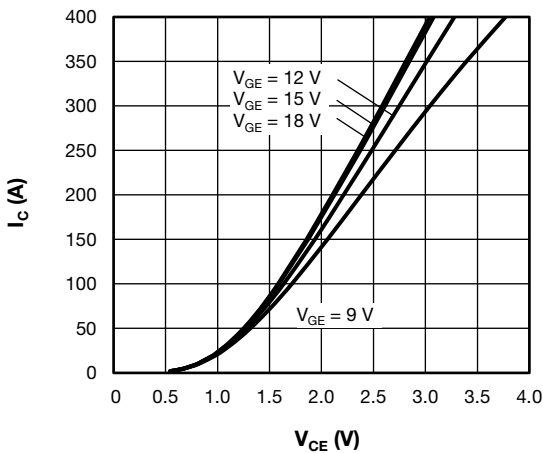


Fig. 2 - Typical Trench IGBT Output Characteristics, $T_J = 125\text{ °C}$

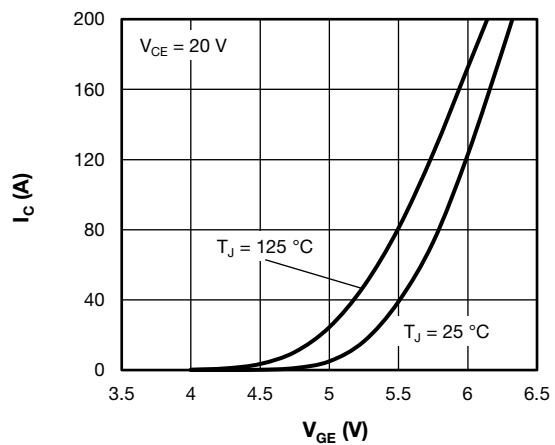


Fig. 4 - Typical Trench IGBT Transfer Characteristics

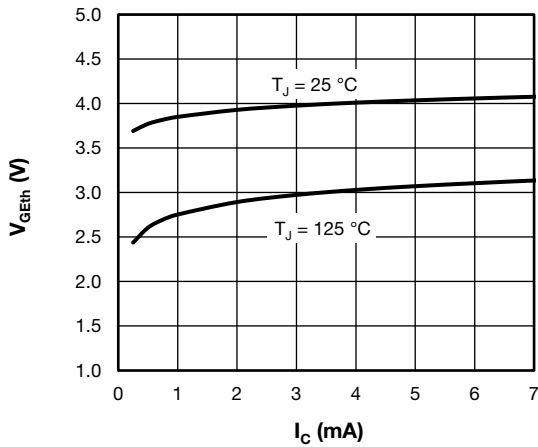


Fig. 5 - Typical Trench IGBT Gate Threshold Voltage

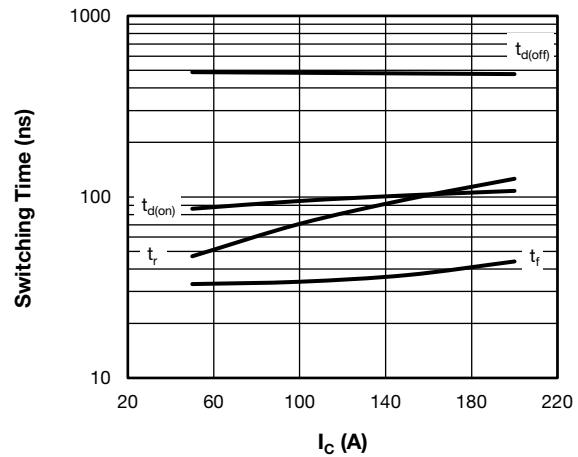


Fig. 8 - Typical Trench IGBT Switching Time vs. I_C
(with Antiparallel Diode)
 $T_J = 125^\circ\text{C}$, $V_{CC} = 325\text{ V}$, $R_g = 27\ \Omega$, $V_{GE} = +15\text{ V}/-15\text{ V}$, $L = 500\ \mu\text{H}$

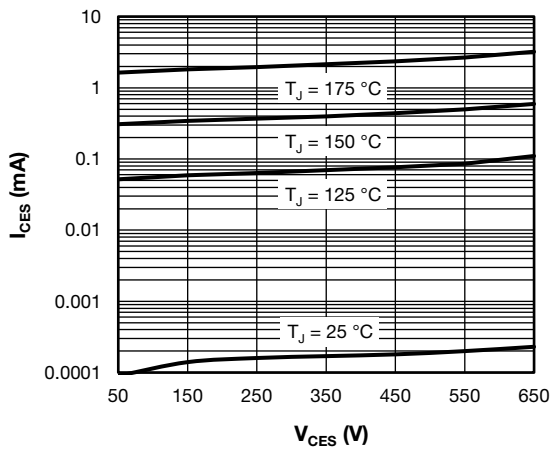


Fig. 6 - Typical Trench IGBT Zero Gate Voltage Collector Current

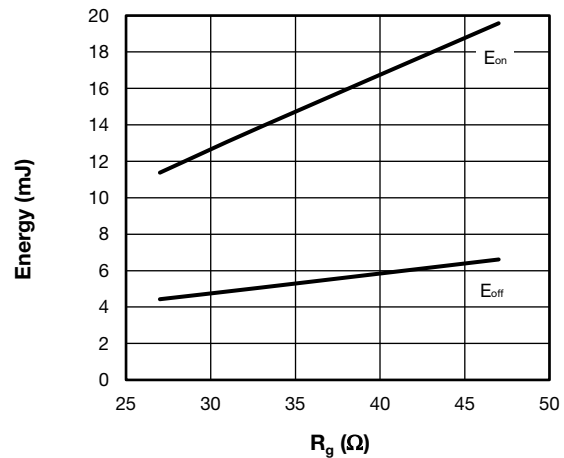


Fig. 9 - Typical Trench IGBT Energy Loss vs. R_g
(with Antiparallel Diode)
 $T_J = 125^\circ\text{C}$, $V_{CC} = 325\text{ V}$, $I_C = 200\text{ A}$, $V_{GE} = +15\text{ V}/-15\text{ V}$, $L = 500\ \mu\text{H}$

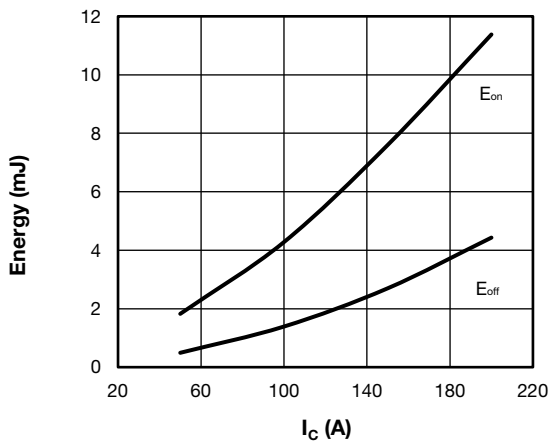


Fig. 7 - Typical Trench IGBT Energy Loss vs. I_C
(with Antiparallel Diode)
 $T_J = 125^\circ\text{C}$, $V_{CC} = 325\text{ V}$, $R_g = 27\ \Omega$, $V_{GE} = +15\text{ V}/-15\text{ V}$, $L = 500\ \mu\text{H}$

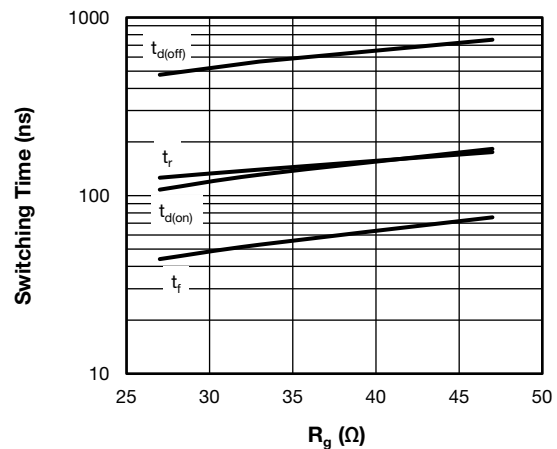


Fig. 10 - Typical Trench IGBT Switching Time vs. R_g
(with Antiparallel Diode)
 $T_J = 125^\circ\text{C}$, $V_{CC} = 325\text{ V}$, $I_C = 200\text{ A}$, $V_{GE} = +15\text{ V}/-15\text{ V}$, $L = 500\ \mu\text{H}$

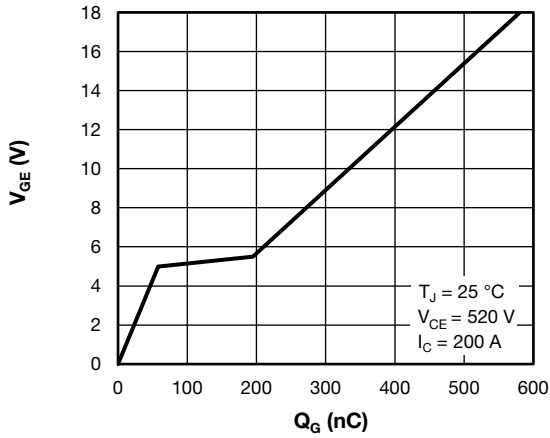


Fig. 11 - Typical Trench IGBT Gate Charge vs. Gate to Collector Voltage

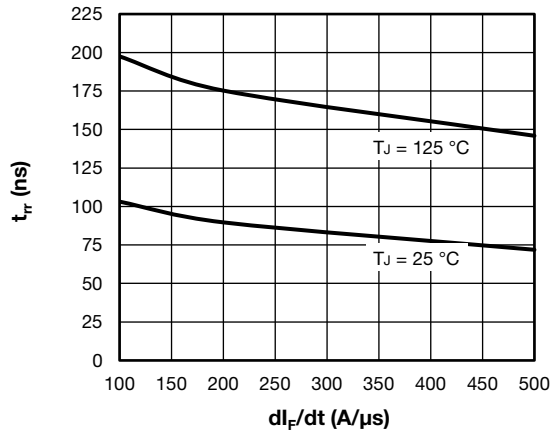


Fig. 14 - Typical Antiparallel Diode Reverse Recovery Time vs. di_F/dt
 $I_F = 50 \text{ A}$, $V_{CC} = 200 \text{ V}$

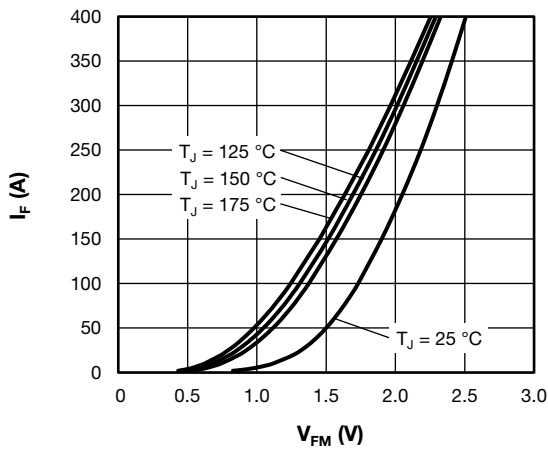


Fig. 12 - Typical Antiparallel Diode Forward Characteristics

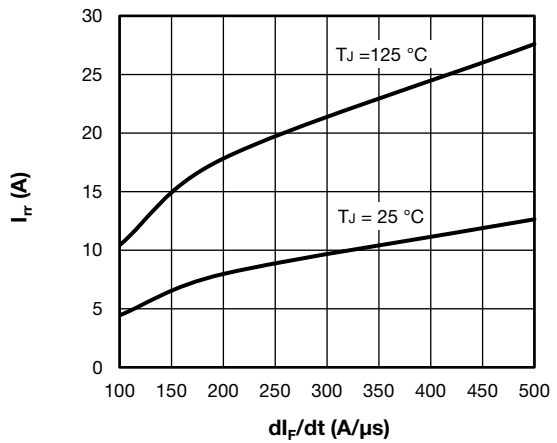


Fig. 15 - Typical Antiparallel Diode Reverse Recovery Current vs. di_F/dt
 $I_F = 50 \text{ A}$, $V_{CC} = 200 \text{ V}$

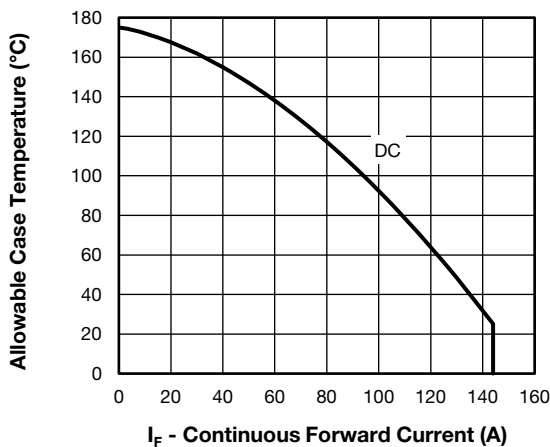


Fig. 13 - Maximum Antiparallel Diode Continuous Forward Current vs. Case Temperature

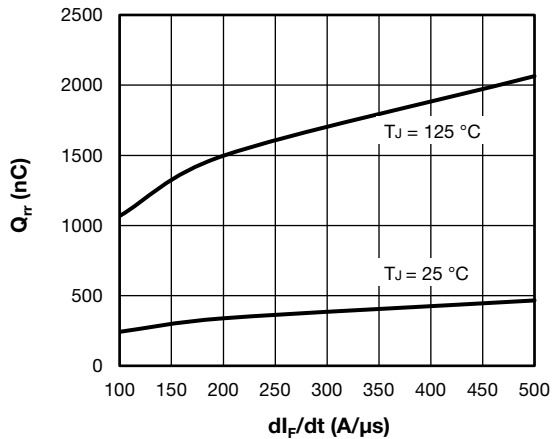


Fig. 16 - Typical Antiparallel Diode Reverse Recovery Charge vs. di_F/dt
 $I_F = 50 \text{ A}$, $V_{CC} = 200 \text{ V}$

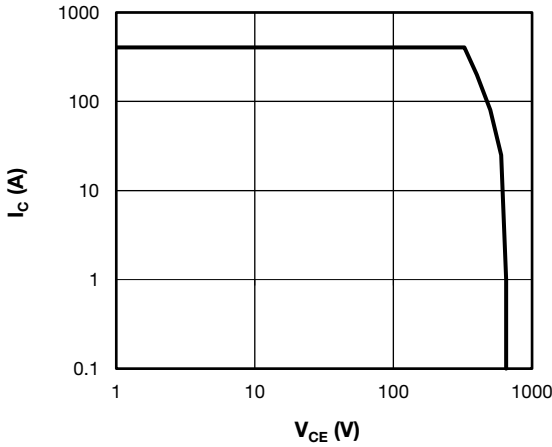


Fig. 17 - Trench IGBT Reverse BIAS SOA
 $T_J = 175^\circ\text{C}$, $I_C = 405\text{ A}$, $R_g = 27\ \Omega$, $V_{GE} = +15\text{ V}/-5\text{ V}$, $V_{CC} = 325\text{ V}$,
 $V_p = 650\text{ V}$

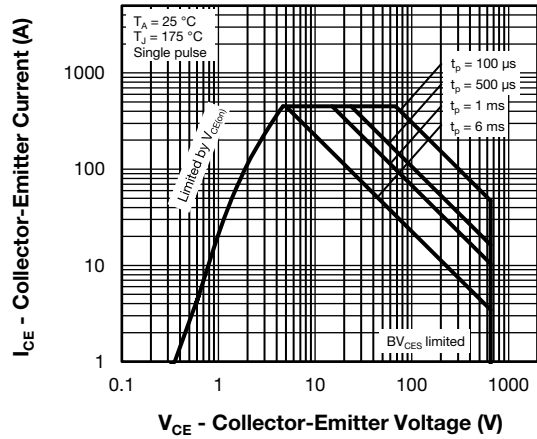


Fig. 18 - Trench IGBT Safe Operating Area

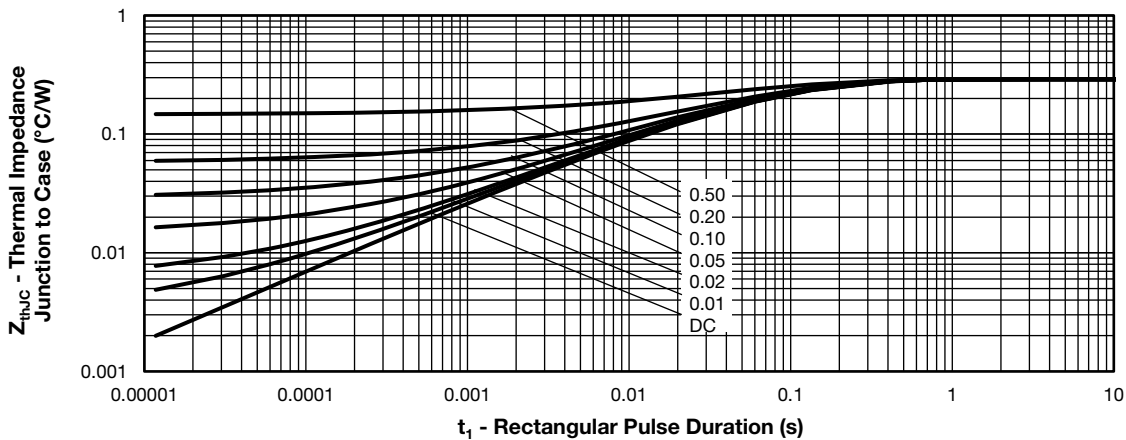


Fig. 19 - Maximum Trench IGBT Thermal Impedance Z_{thJC} Characteristics

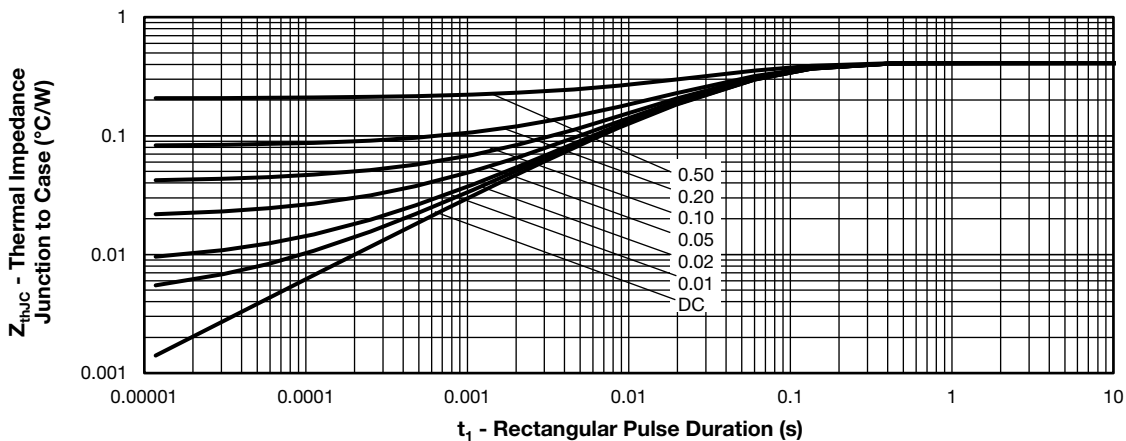
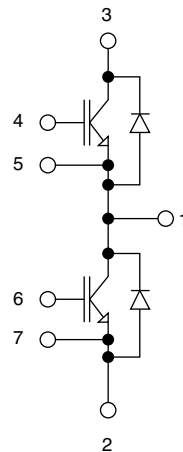


Fig. 20 - Maximum Antiparallel Diode Thermal Impedance Z_{thJC} Characteristics

ORDERING INFORMATION TABLE

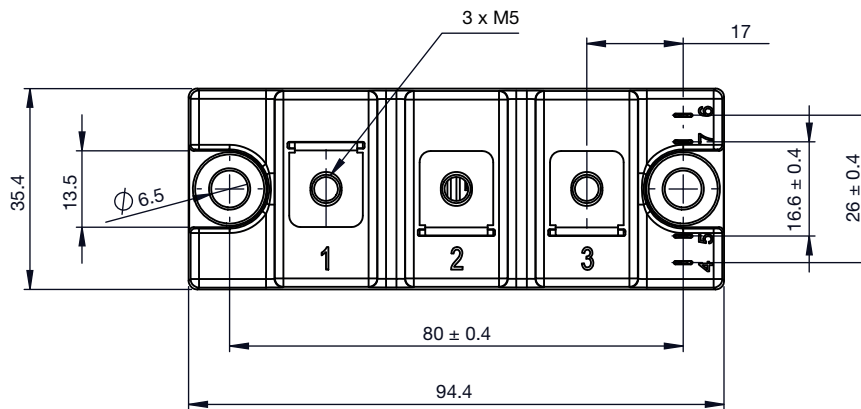
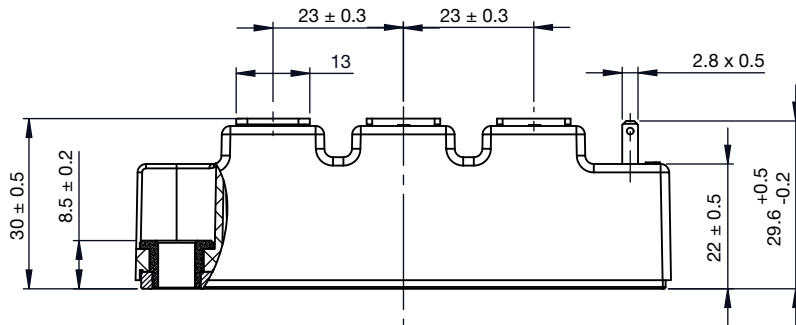
| | | | | | | | | |
|-------------|------------|----------|----------|------------|----------|----------|------------|----------|
| Device code | VS- | G | T | 200 | T | S | 065 | N |
| | 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 |

- 1** - Vishay Semiconductors product
- 2** - Insulated gate bipolar transistor (IGBT)
- 3** - T = trench IGBT
- 4** - Current rating (200 = 200 A)
- 5** - Circuit configuration (T = half bridge)
- 6** - Package indicator (S = INT-A-PAK IGBT)
- 7** - Voltage rating (065 = 650 V)
- 8** - Speed/type (N = ultrafast IGBT)

CIRCUIT CONFIGURATION




DIMENSIONS in millimeters



General tolerance ± 0.5 mm



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